

# DATA SHEET

## **BF1201; BF1201R; BF1201WR** N-channel dual-gate PoLo MOS-FETs

Product specification  
Supersedes data of 1999 Dec 01

2000 Mar 29



# N-channel dual-gate PoLo MOS-FETs

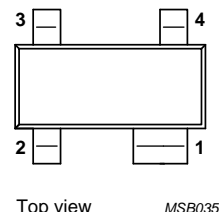
## BF1201; BF1201R; BF1201WR

### FEATURES

- Short channel transistor with high forward transfer admittance to input capacitance ratio
- Low noise gain controlled amplifier
- Partly internal self-biasing circuit to ensure good cross-modulation performance during AGC and good DC stabilization.

### PINNING

PIN	DESCRIPTION
1	source
2	drain
3	gate 2
4	gate 1



BF1201R marking code: LBp

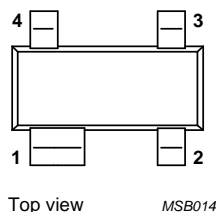
Fig.2 Simplified outline (SOT143R).

### APPLICATIONS

- VHF and UHF applications with 3 to 9 V supply voltage, such as digital and analogue television tuners and professional communications equipment.

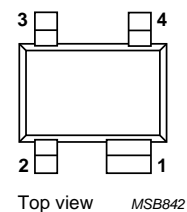
### DESCRIPTION

Enhancement type N-channel field-effect transistor with source and substrate interconnected. Integrated diodes between gates and source protect against excessive input voltage surges. The BF1201, BF1201R and BF1201WR are encapsulated in the SOT143B, SOT143R and SOT343R plastic packages respectively.



BF1201 marking code: LAp.

Fig.1 Simplified outline (SOT143B).



BF1201WR marking code: LA

Fig.3 Simplified outline (SOT343R).

### QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{DS}$	drain-source voltage		–	–	10	V
$I_D$	drain current		–	–	30	mA
$P_{tot}$	total power dissipation		–	–	200	mW
$ y_{fs} $	forward transfer admittance		23	28	35	mS
$C_{ig1-ss}$	input capacitance at gate 1		–	2.6	3.1	pF
$C_{rss}$	reverse transfer capacitance	$f = 1 \text{ MHz}$	–	15	30	fF
$F$	noise figure	$f = 400 \text{ MHz}$	–	1	1.8	dB
$X_{mod}$	cross-modulation	input level for $k = 1\%$ at 40 dB AGC	105	–	–	dB $\mu$ V
$T_j$	operating junction temperature		–	–	150	°C

### CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling.

N-channel dual-gate PoLo MOS-FETs

BF1201; BF1201R; BF1201WR

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

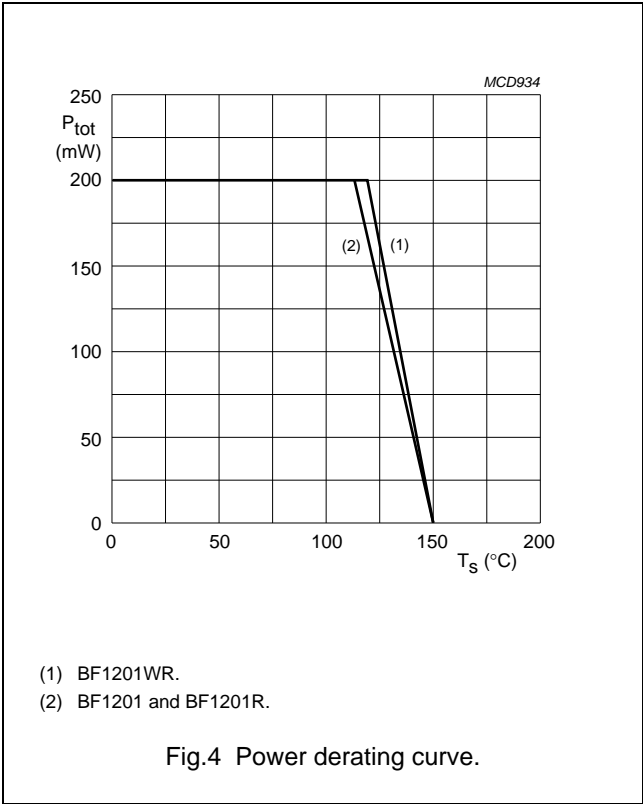
SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>DS</sub>	drain-source voltage		–	10	V
I <sub>D</sub>	drain current (DC)		–	30	mA
I <sub>G1</sub>	gate 1 current		–	±10	mA
I <sub>G2</sub>	gate 2 current		–	±10	mA
P <sub>tot</sub>	total power dissipation				
	BF1201; BF1201R	T <sub>s</sub> ≤ 113 °C; note 1	–	200	mW
	BF1201WR	T <sub>s</sub> ≤ 109 °C; note 1	–	200	mW
T <sub>stg</sub>	storage temperature		–65	+150	°C
T <sub>j</sub>	operating junction temperature		–	150	°C

Note

1. T<sub>s</sub> is the temperature of the soldering point of the source lead.

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	VALUE	UNIT
R <sub>th j-s</sub>	thermal resistance from junction to soldering point		
	BF1201; BF1201R	185	K/W
	BF1201WR	155	K/W



## N-channel dual-gate PoLo MOS-FETs

BF1201; BF1201R; BF1201WR

## STATIC CHARACTERISTICS

 $T_j = 25\text{ }^{\circ}\text{C}$ ; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{(BR)DSS}$	drain-source breakdown voltage	$V_{G1-S} = V_{G2-S} = 0$ ; $I_D = 10\text{ }\mu\text{A}$	10	–	V
$V_{(BR)G1-SS}$	gate 1-source breakdown voltage	$V_{G2-S} = V_{DS} = 0$ ; $I_{G1-S} = 10\text{ mA}$	6	–	V
$V_{(BR)G2-SS}$	gate 2-source breakdown voltage	$V_{G1-S} = V_{DS} = 0$ ; $I_{G2-S} = 10\text{ mA}$	6	–	V
$V_{(F)S-G1}$	forward source-gate 1 voltage	$V_{G2-S} = V_{DS} = 0$ ; $I_{S-G1} = 10\text{ mA}$	0.5	1.5	V
$V_{(F)S-G2}$	forward source-gate 2 voltage	$V_{G1-S} = V_{DS} = 0$ ; $I_{S-G2} = 10\text{ mA}$	0.5	1.5	V
$V_{G1-S(th)}$	gate 1-source threshold voltage	$V_{G2-S} = 4\text{ V}$ ; $V_{DS} = 5\text{ V}$ ; $I_D = 100\text{ }\mu\text{A}$	0.3	1.0	V
$V_{G2-S(th)}$	gate 2-source threshold voltage	$V_{G1-S} = V_{DS} = 5\text{ V}$ ; $I_D = 100\text{ }\mu\text{A}$	0.3	1.2	V
$I_{DSX}$	drain-source current	$V_{G2-S} = 4\text{ V}$ ; $V_{DS} = 5\text{ V}$ ; $R_{G1} = 62\text{ k}\Omega$ ; note 1	11	19	mA
$I_{G1-SS}$	gate 1 cut-off current	$V_{G2-S} = V_{DS} = 0$ ; $V_{G1-S} = 5\text{ V}$	–	50	nA
$I_{G2-SS}$	gate 2 cut-off current	$V_{G1-S} = V_{DS} = 0$ ; $V_{G2-S} = 4\text{ V}$	–	20	nA

## Note

1.  $R_{G1}$  connects  $G_1$  to  $V_{GG} = 5\text{ V}$ .

## DYNAMIC CHARACTERISTICS

Common source;  $T_{amb} = 25\text{ }^{\circ}\text{C}$ ;  $V_{G2-S} = 4\text{ V}$ ;  $V_{DS} = 5\text{ V}$ ;  $I_D = 15\text{ mA}$ ; unless otherwise specified.

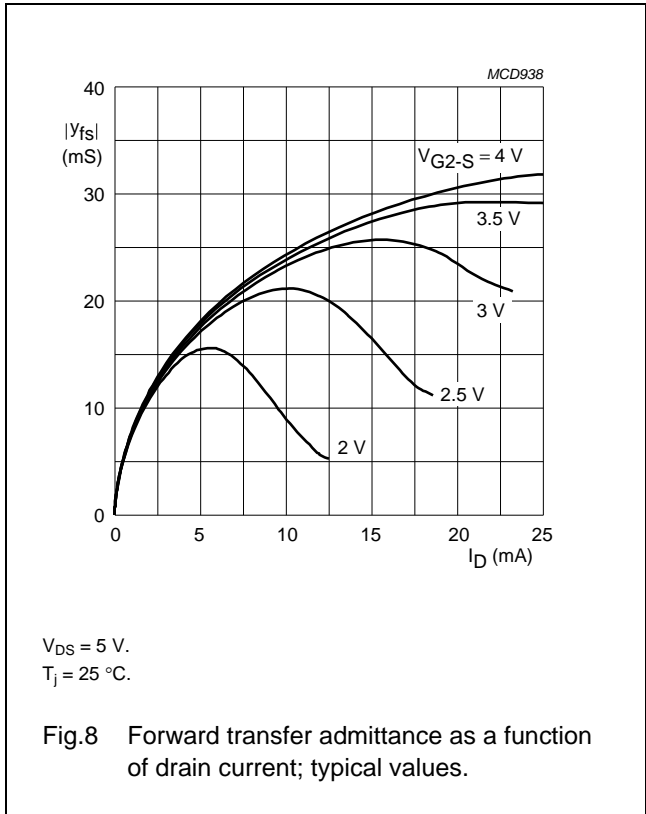
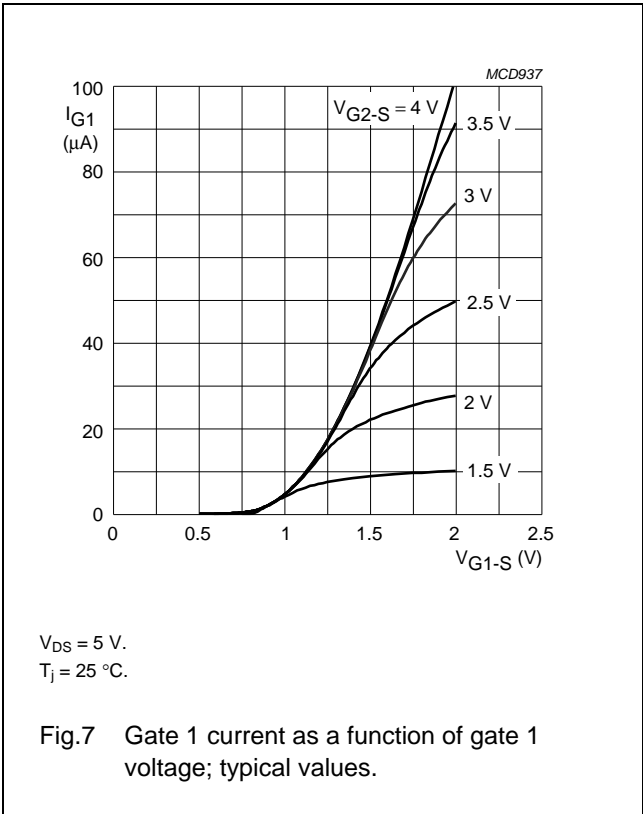
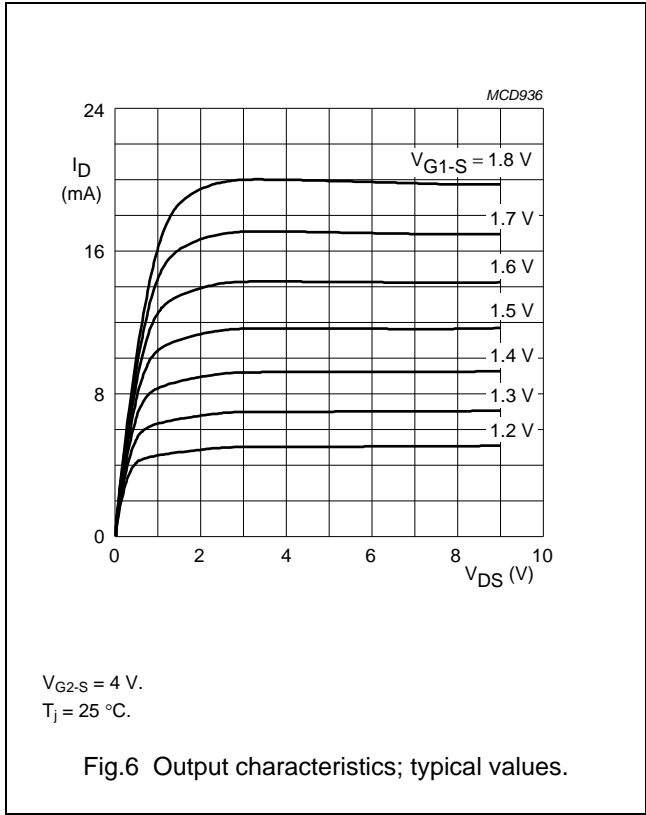
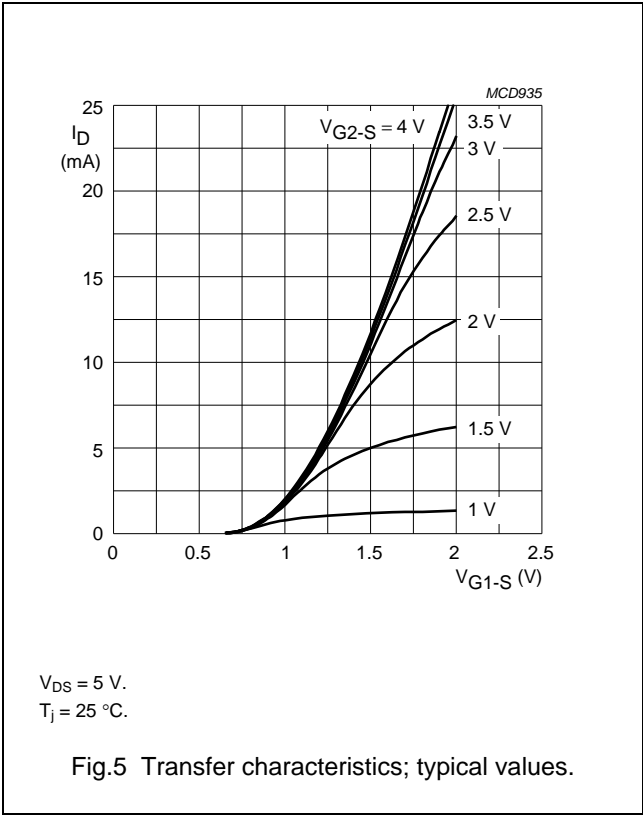
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$ y_{fs} $	forward transfer admittance	pulsed; $T_j = 25\text{ }^{\circ}\text{C}$	23	28	35	mS
$C_{ig1-ss}$	input capacitance at gate 1	$f = 1\text{ MHz}$	–	2.6	3.1	pF
$C_{ig2-ss}$	input capacitance at gate 2	$f = 1\text{ MHz}$	–	1.1	–	pF
$C_{oss}$	output capacitance	$f = 1\text{ MHz}$	–	0.9	–	pF
$C_{rss}$	reverse transfer capacitance	$f = 1\text{ MHz}$	–	15	30	fF
F	noise figure	$f = 10.7\text{ MHz}$ ; $G_S = 20\text{ mS}$ ; $B_S = 0$	–	5	7	dB
		$f = 400\text{ MHz}$ ; $Y_S = Y_{S\text{ opt}}$	–	1	1.8	dB
		$f = 800\text{ MHz}$ ; $Y_S = Y_{S\text{ opt}}$	–	1.9	2.5	dB
$G_{tr}$	power gain	$f = 200\text{ MHz}$ ; $G_S = 2\text{ mS}$ ; $B_S = B_{S\text{ opt}}$ ; $G_L = 0.5\text{ mS}$ ; $B_L = B_{L\text{ opt}}$	–	33.5	–	dB
		$f = 400\text{ MHz}$ ; $G_S = 2\text{ mS}$ ; $B_S = B_{S\text{ opt}}$ ; $G_L = 1\text{ mS}$ ; $B_L = B_{L\text{ opt}}$	–	29	–	dB
		$f = 800\text{ MHz}$ ; $G_S = 3.3\text{ mS}$ ; $B_S = B_{S\text{ opt}}$ ; $G_L = 1\text{ mS}$ ; $B_L = B_{L\text{ opt}}$	–	24	–	dB
$X_{mod}$	cross-modulation	input level for $k = 1\%$ ; $f_w = 50\text{ MHz}$ ; $f_{unw} = 60\text{ MHz}$ ; note 1				
		at 0 dB AGC	90	–	–	dB $\mu$ V
		at 10 dB AGC	–	95	–	dB $\mu$ V
		at 40 dB AGC	105	–	–	dB $\mu$ V

## Note

1. Measured in Fig.21 test circuit.

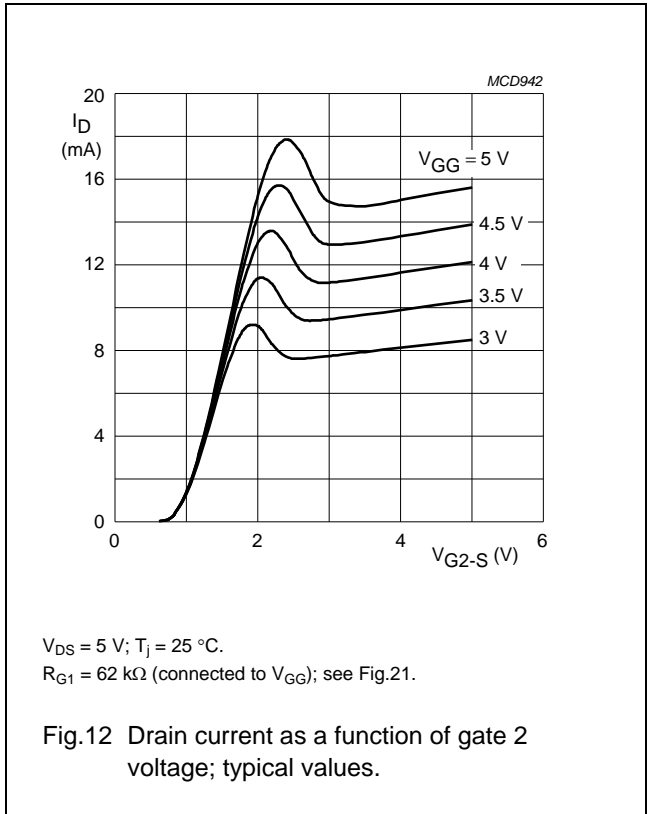
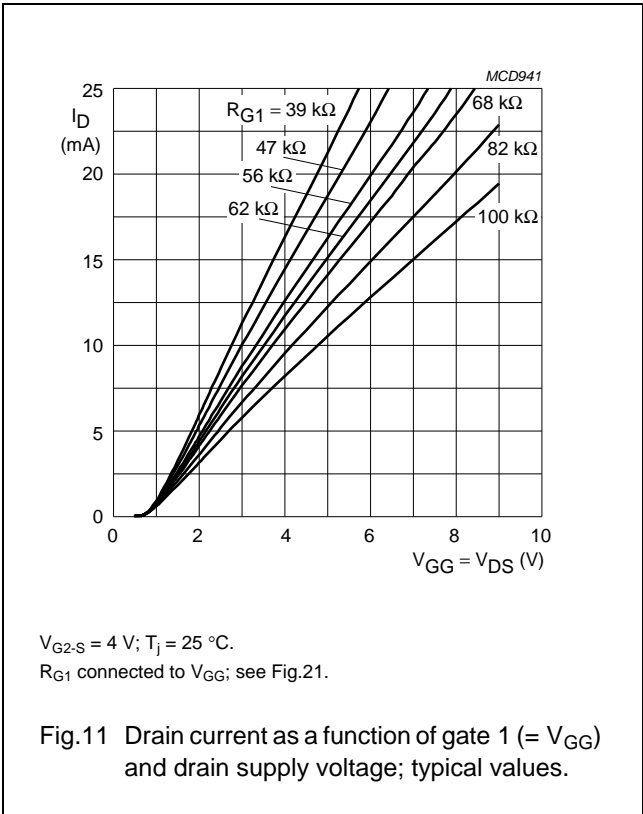
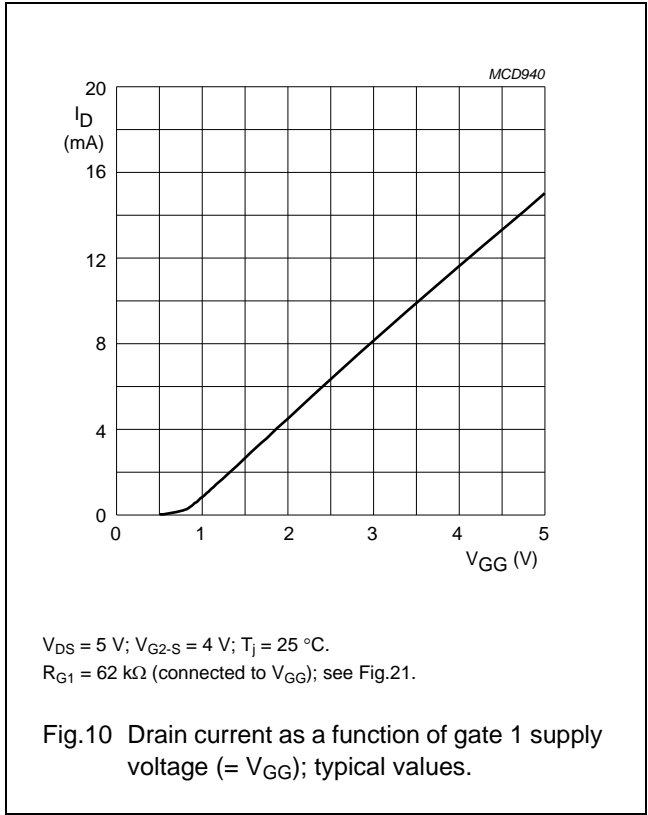
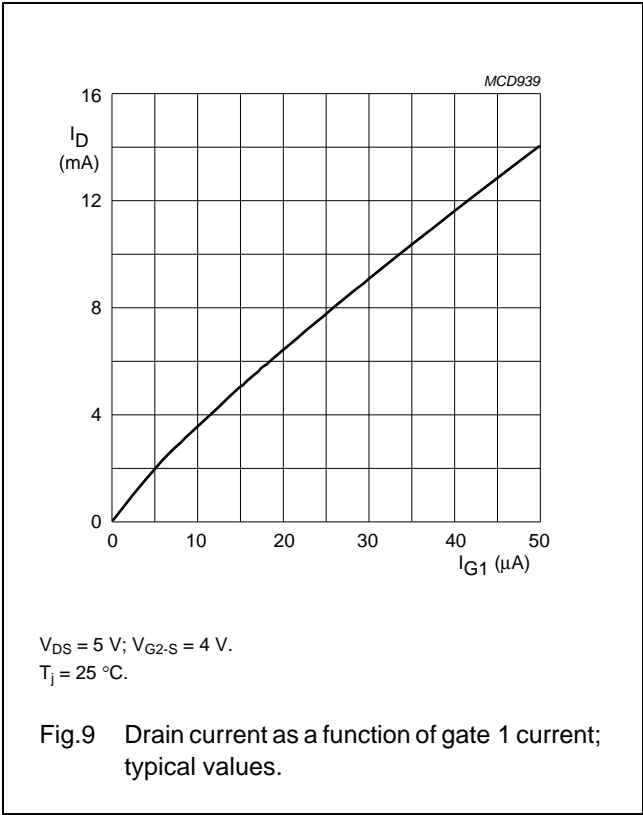
N-channel dual-gate PoLo MOS-FETs

BF1201; BF1201R; BF1201WR



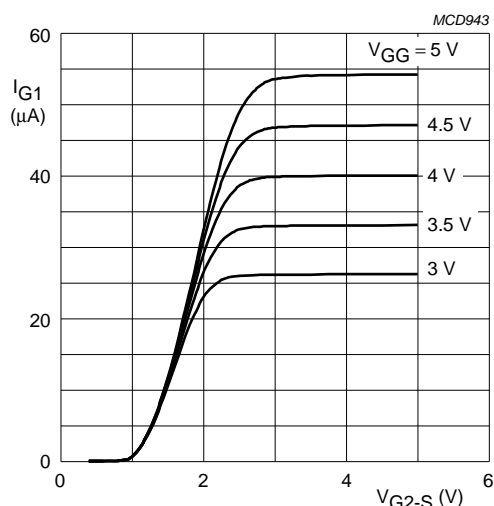
N-channel dual-gate PoLo MOS-FETs

BF1201; BF1201R; BF1201WR



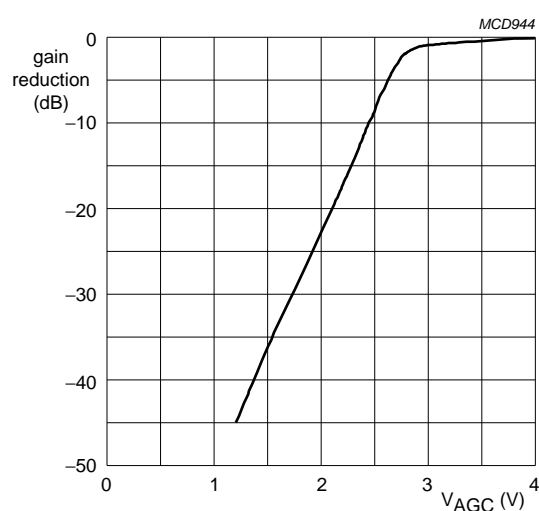
## N-channel dual-gate PoLo MOS-FETs

## BF1201; BF1201R; BF1201WR



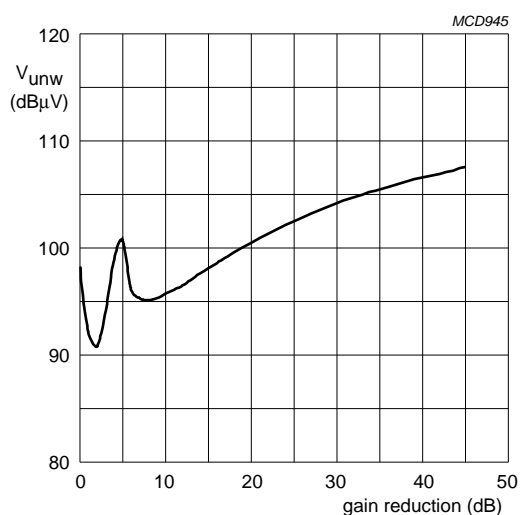
$V_{DS} = 5 V$ ;  $T_j = 25^\circ C$ .  
 $R_{G1} = 62 k\Omega$  (connected to  $V_{GG}$ ); see Fig.21.

Fig.13 Gate 1 current as a function of gate 2 voltage; typical values.



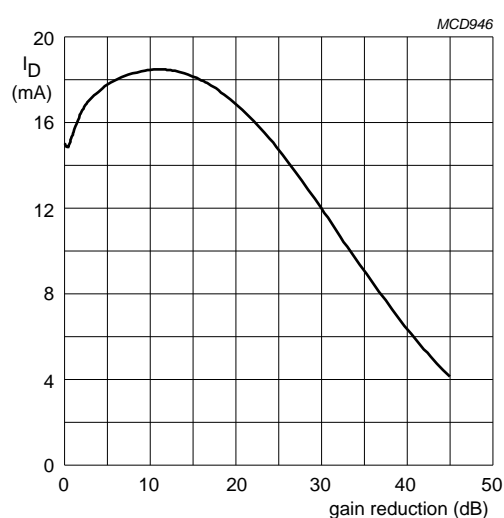
$V_{DS} = 5 V$ ;  $V_{GG} = 5 V$ ;  $R_{G1} = 62 k\Omega$ ;  
 $f = 50 MHz$ ;  $T_{amb} = 25^\circ C$ .

Fig.14 Typical gain reduction as a function of the AGC voltage; see Fig.21.



$V_{DS} = 5 V$ ;  $V_{GG} = 5 V$ ;  $R_{G1} = 62 k\Omega$ ;  $f = 50 MHz$ ;  
 $f_{unw} = 60 MHz$ ;  $T_{amb} = 25^\circ C$ .

Fig.15 Unwanted voltage for 1% cross-modulation as a function of gain reduction; typical values; see Fig.21.

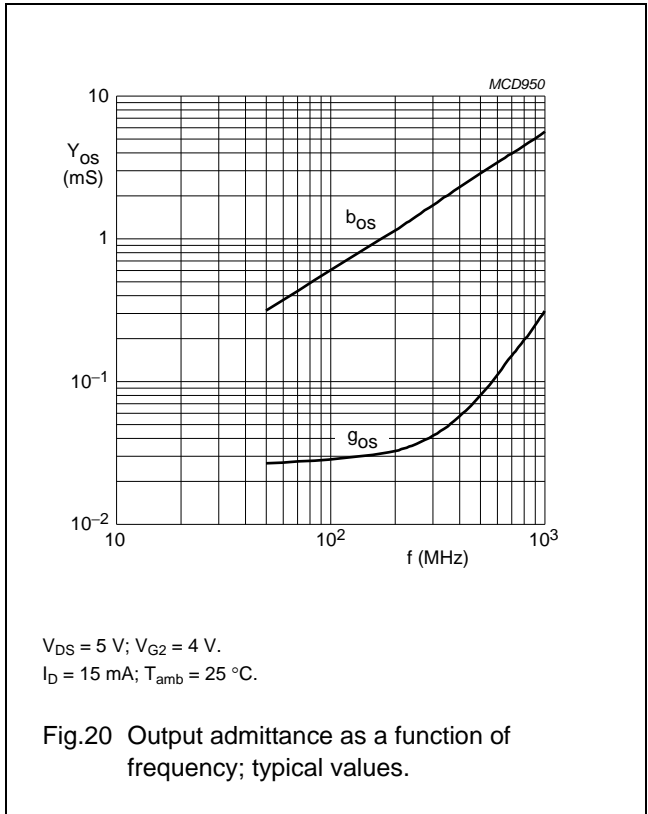
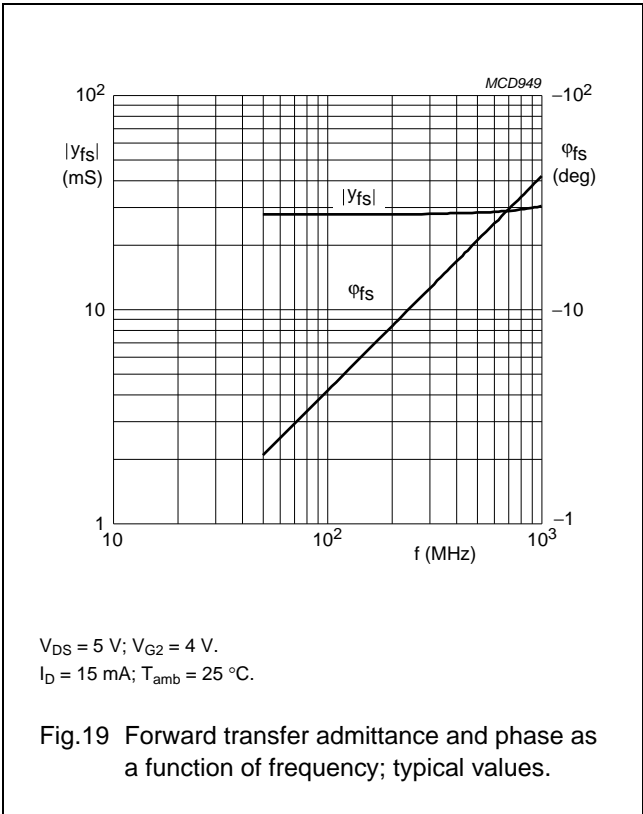
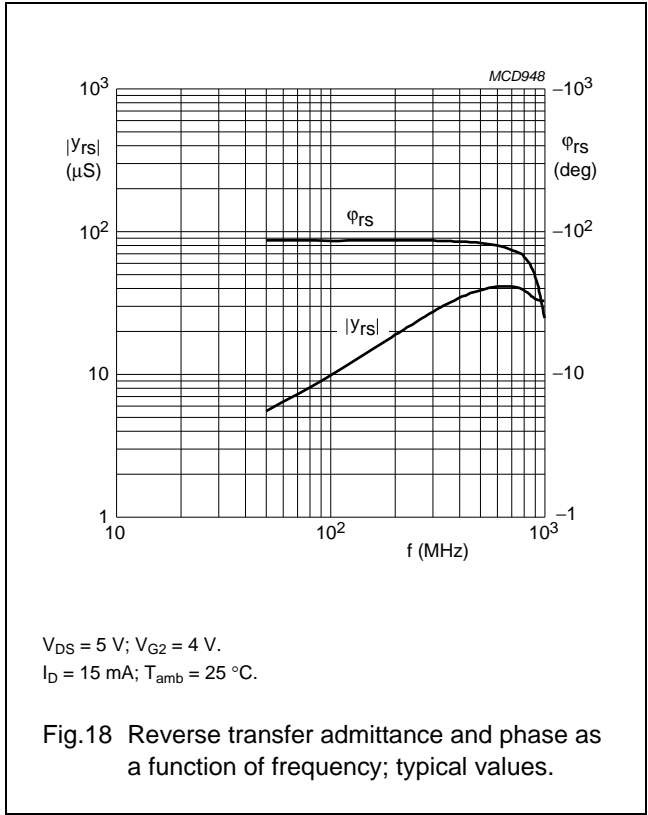
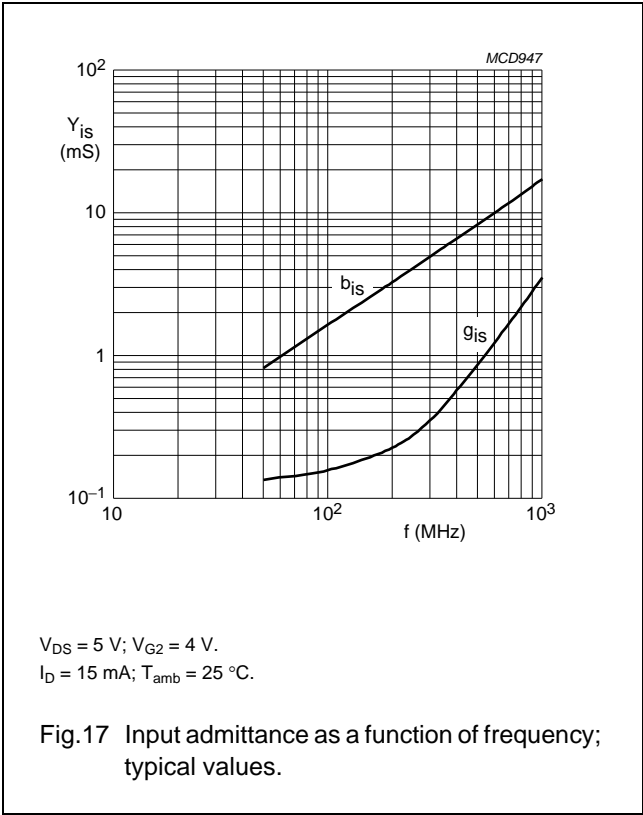


$V_{DS} = 5 V$ ;  $V_{GG} = 5 V$ ;  $R_{G1} = 62 k\Omega$ ;  
 $f = 50 MHz$ ;  $T_{amb} = 25^\circ C$ .

Fig.16 Drain current as a function of gain reduction; typical values; see Fig.21.

N-channel dual-gate PoLo MOS-FETs

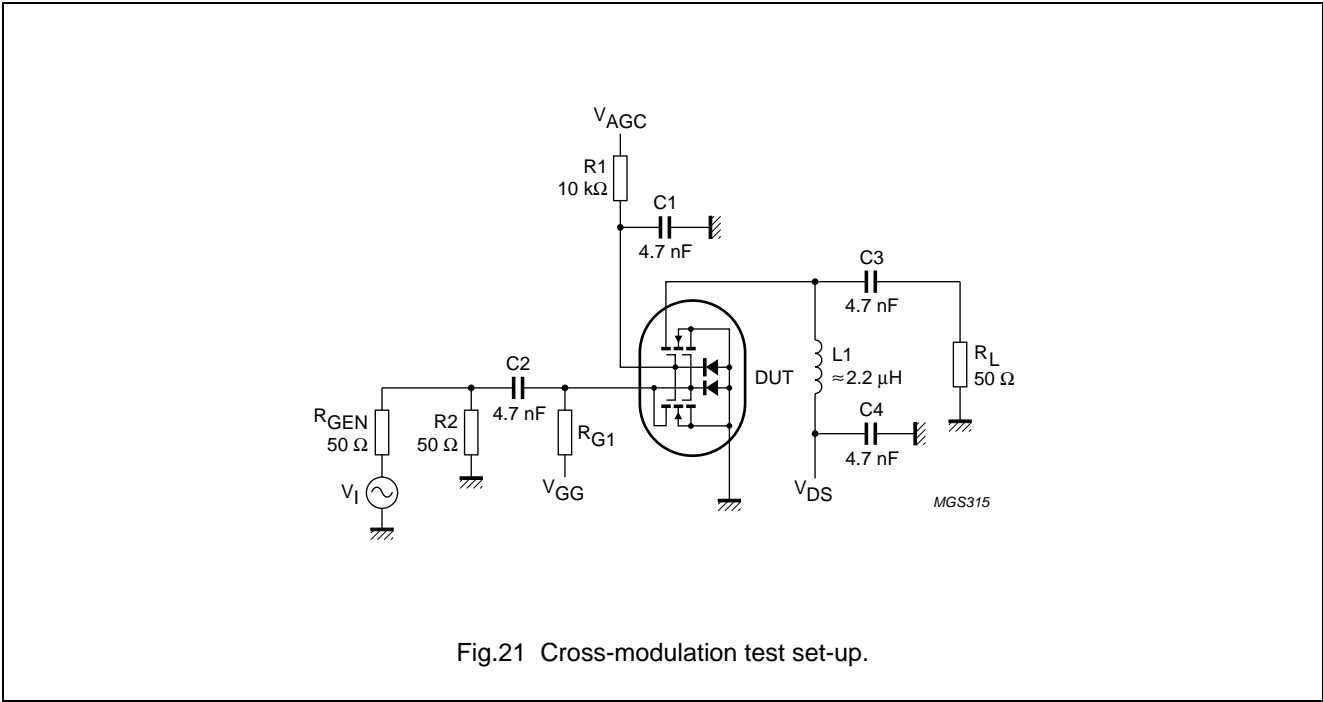
BF1201; BF1201R; BF1201WR





N-channel dual-gate PoLo MOS-FETs

BF1201; BF1201R; BF1201WR



**Table 1** Scattering parameters:  $V_{DS} = 5\text{ V}$ ;  $V_{G2-S} = 4\text{ V}$ ;  $I_D = 15\text{ mA}$ ;  $T_{amb} = 25\text{ }^{\circ}\text{C}$

f (MHz)	S <sub>11</sub>		S <sub>21</sub>		S <sub>12</sub>		S <sub>22</sub>	
	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)
50	0.987	−4.72	2.775	174.6	0.0006	88.8	0.997	−1.84
100	0.985	−9.39	2.774	169.5	0.0010	86.7	0.997	−3.37
200	0.978	−18.59	2.731	159.1	0.0019	79.7	0.996	−6.72
300	0.976	−27.74	2.671	148.8	0.0026	74.2	0.994	−10.02
400	0.949	−36.59	2.599	138.8	0.0032	69.9	0.992	−13.33
500	0.928	−45.08	2.501	129.1	0.0035	65.9	0.989	−16.55
600	0.905	−53.26	2.400	119.8	0.0035	64.6	0.986	−19.64
700	0.882	−61.07	2.297	110.9	0.0033	65.7	0.982	−22.63
800	0.860	−68.48	2.199	102.4	0.0029	69.1	0.979	−25.54
900	0.838	−75.55	2.096	94.2	0.0024	83.3	0.975	−28.44
1000	0.818	−82.23	1.997	86.3	0.0021	103.8	0.971	−31.42

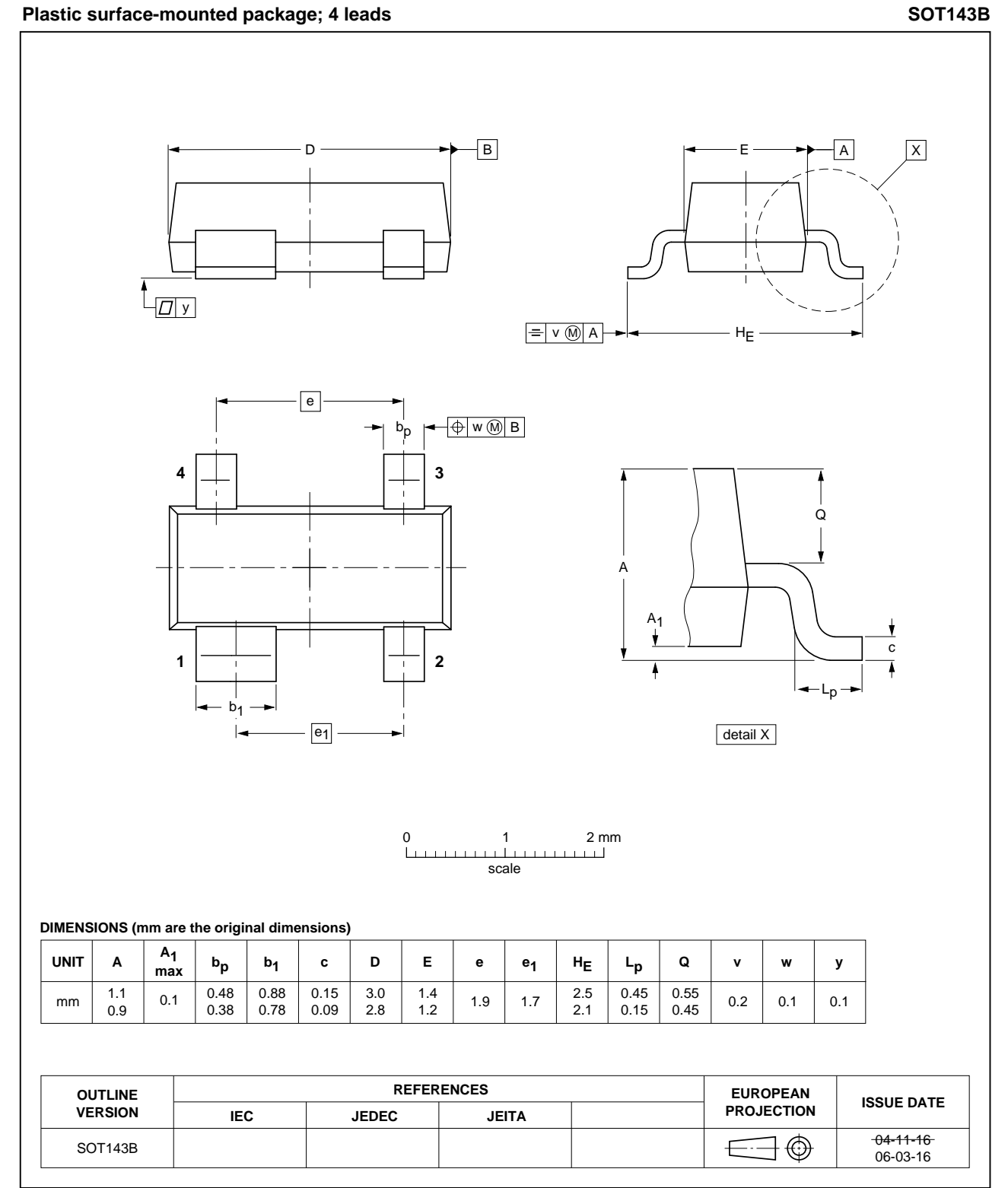
**Table 2** Noise data:  $V_{DS} = 5\text{ V}$ ;  $V_{G2-S} = 4\text{ V}$ ;  $I_D = 15\text{ mA}$ ;  $T_{amb} = 25\text{ }^{\circ}\text{C}$

f (MHz)	F <sub>min</sub> (dB)	Γ <sub>opt</sub>		R <sub>n</sub> (Ω)
		(ratio)	(deg)	
400	1	0.825	38.93	50
800	1.9	0.753	70.65	38.75

N-channel dual-gate PoLo MOS-FETs

BF1201; BF1201R; BF1201WR

PACKAGE OUTLINES

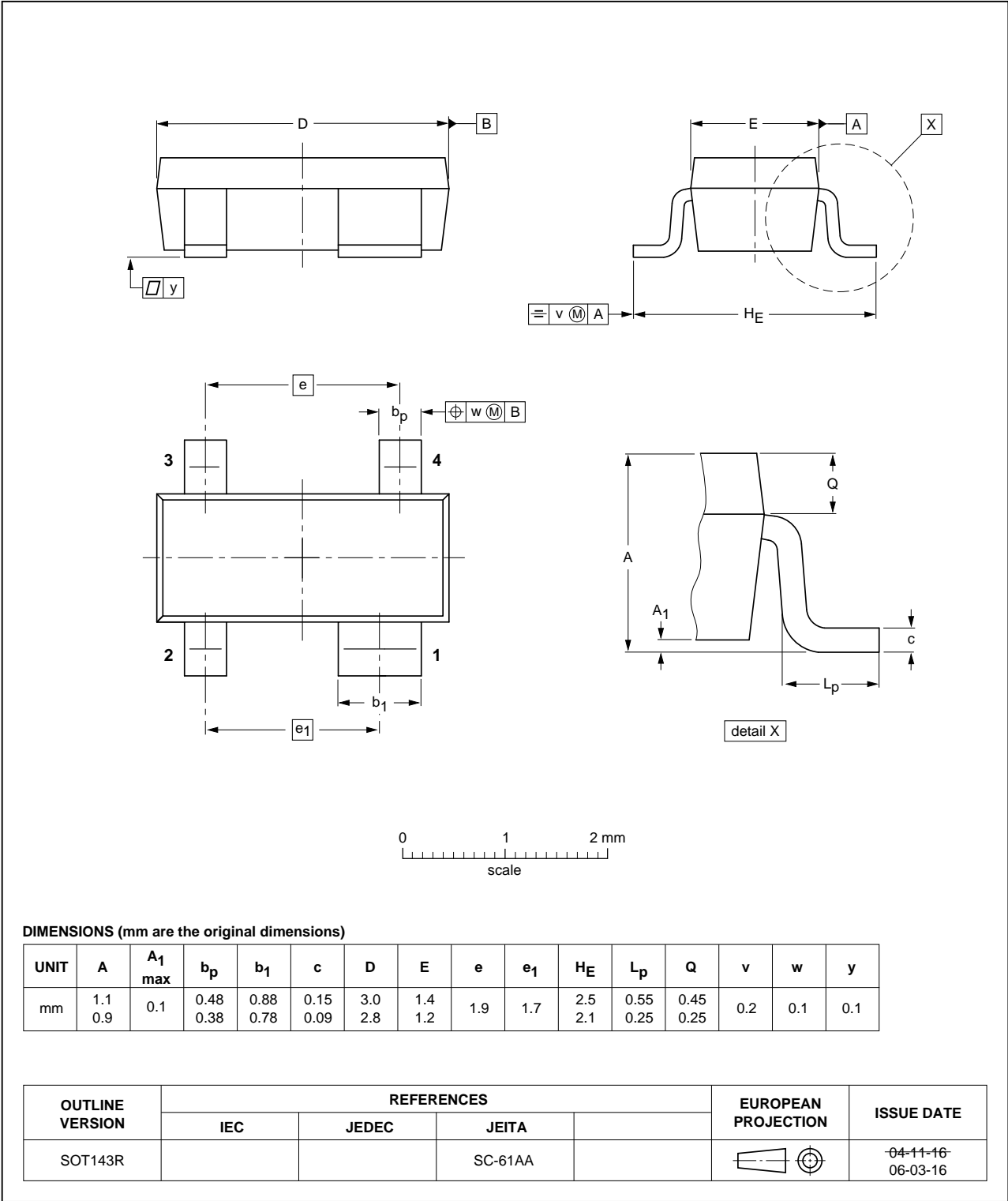


N-channel dual-gate PoLo MOS-FETs

BF1201; BF1201R; BF1201WR

Plastic surface-mounted package; reverse pinning; 4 leads

SOT143R

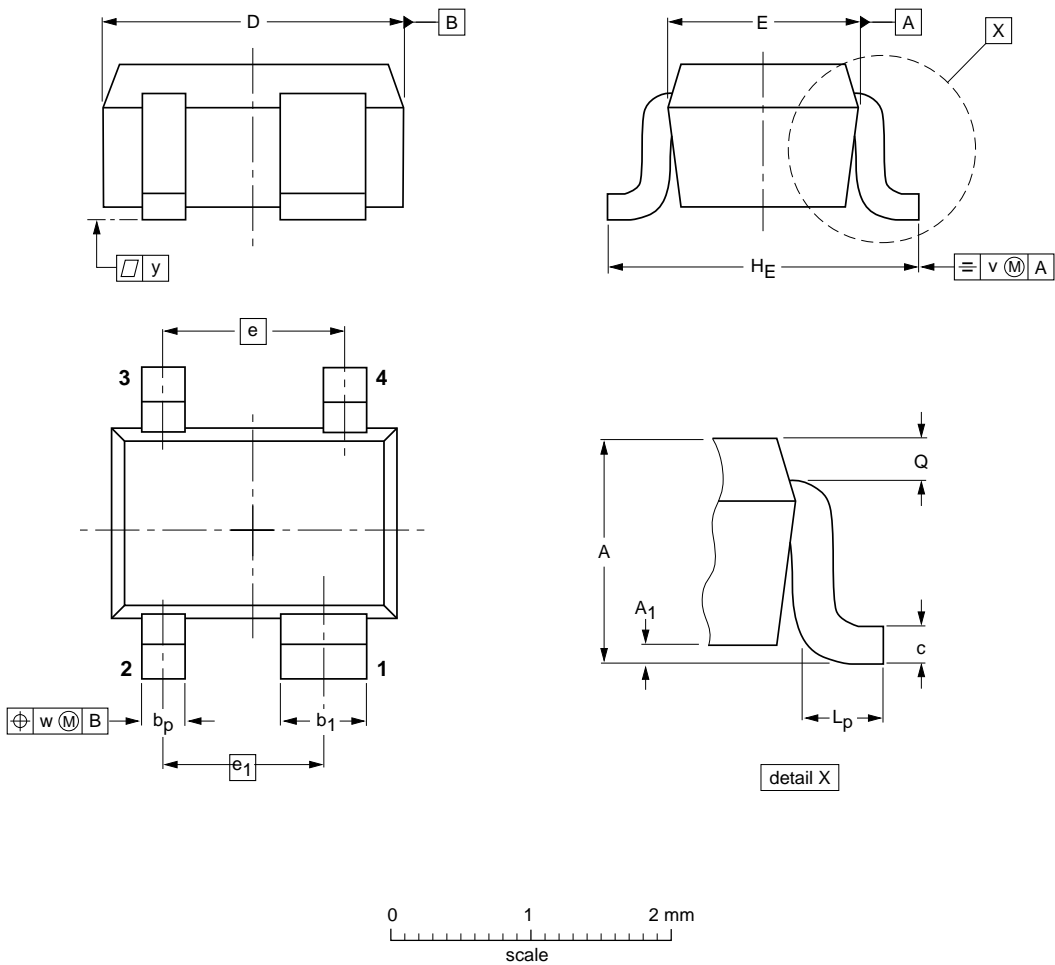


N-channel dual-gate PoLo MOS-FETs

BF1201; BF1201R; BF1201WR

Plastic surface-mounted package; reverse pinning; 4 leads

SOT343R



DIMENSIONS (mm are the original dimensions)

UNIT	A	A <sub>1</sub> max	b <sub>p</sub>	b <sub>1</sub>	c	D	E	e	e <sub>1</sub>	H <sub>E</sub>	L <sub>p</sub>	Q	v	w	y
mm	1.1 0.8	0.1	0.4 0.3	0.7 0.5	0.25 0.10	2.2 1.8	1.35 1.15	1.3	1.15	2.2 2.0	0.45 0.15	0.23 0.13	0.2	0.2	0.1

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT343R						97-05-21 06-03-16

## N-channel dual-gate PoLo MOS-FETs

BF1201; BF1201R; BF1201WR

## DATA SHEET STATUS

DOCUMENT STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)</sup>	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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1. Please consult the most recently issued document before initiating or completing a design.
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N-channel dual-gate PoLo MOS-FETsBF1201; BF1201R; BF1201WR

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## **Contact information**

For additional information please visit: <http://www.nxp.com>

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Printed in The Netherlands

R77/02/pp15

Date of release: 2000 Mar 29

# AMEYA360

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#### ➤ Customer Service :

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